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N-Channel 600V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	600			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	2.3		
Q _g (Max.) (nC)	31			
Q _{gs} (nC)	4.6			
Q _{gd} (nC)	17			
Configuration	Single			

FEATURES

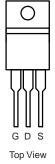
- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s;



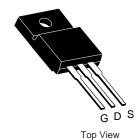
- Sink to Lead Creepage Distance = 4.8 mm
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available



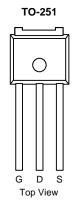


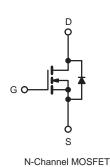






TO-252 D S Top View





ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherv	vise noted		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	600	V
Gate-Source Voltage			V_{GS}	± 20	V
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	- I _D	2.0	
		T _C = 100 °C		1.6	Α
Pulsed Drain Current ^a			I _{DM}	10	
Linear Derating Factor				0.28	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ
Repetitive Avalanche Current ^a			I _{AR}	2.5	А
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ
Maximum Power Dissipation	T _C = 25 °C		P_{D}	35	W
Peak Diode Recovery dV/dtc			dV/dt	3.0	V/ns
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 _q	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in
				1.1	N · m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 50 V, starting T_J = 25 °C, L = 73 mH, R_G = 25 Ω , I_{AS} = 1.5 A (see fig. 12).
- c. $I_{SD} \le 1.6$ A, $dI/dt \le 60$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	600	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	-	0.62	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
7. 0.1 1/11. 10.10. 1		V _{DS} =	V _{DS} = 600 V, V _{GS} = 0 V		-	100	,.,
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 480 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.5 A ^b	-	2.3	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 1.5 A ^b	2.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	660	-	pF
Output Capacitance	C _{oss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		86	-	
Reverse Transfer Capacitance	C _{rss}	f = 1			19	-	
Drain to Sink Capacitance	С	f = 1.0 MHz		-	12	-	
Total Gate Charge	Qg		I _D = 1.6 A, V _{DS} = 360 V, see fig. 6 and 13 ^b	-	-	31	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	4.6	
Gate-Drain Charge	Q _{gd}	1		-	-	17	
Turn-On Delay Time	t _{d(on)}			-	11	-	
Rise Time	t _r	$V_{DD} = 300 \text{ V, } I_D = 1.6 \text{ A,}$ $R_G = 12 \Omega, R_D = 82 \Omega,$ see fig. 10^b		-	13	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	35	-	
Fall Time	t _f			-	14	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the		-	2.0	А
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	10	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 1.5 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 1.6 A, dl/dt = 100 A/μs ^b			400	810	ns
Body Diode Reverse Recovery Charge	Q_{rr}			_	2.1	4.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_{\Box}				_D)	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

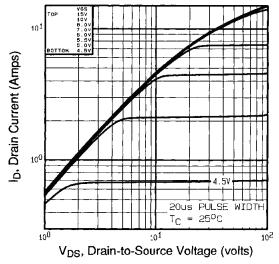


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

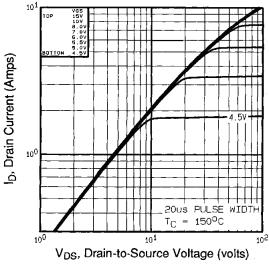


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

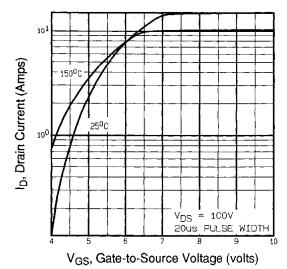


Fig. 3 - Typical Transfer Characteristics

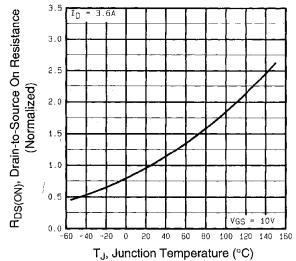


Fig. 4 - Normalized On-Resistance vs. Temperature



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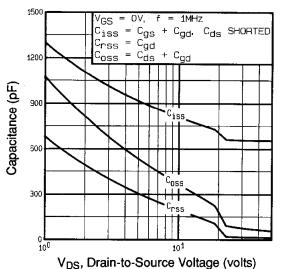


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

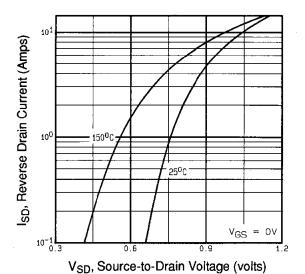


Fig. 7 - Typical Source-Drain Diode Forward Voltage

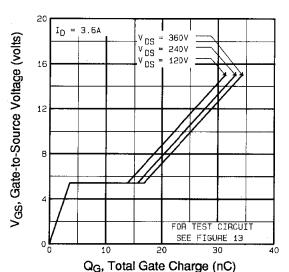


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

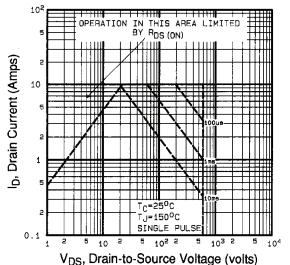


Fig. 8 - Maximum Safe Operating Area



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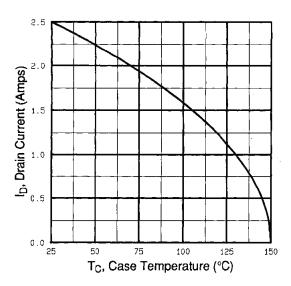


Fig. 9 - Maximum Drain Current vs. Case Temperature

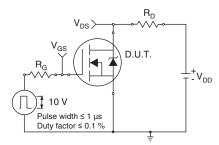


Fig. 10a - Switching Time Test Circuit

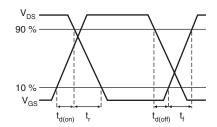


Fig. 10b - Switching Time Waveforms

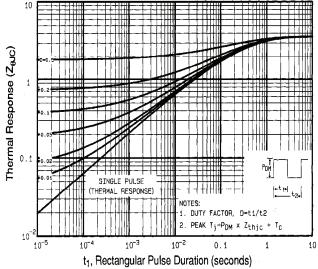


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

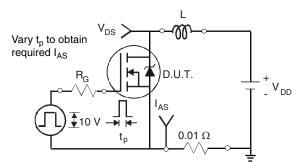


Fig. 12a - Unclamped Inductive Test Circuit

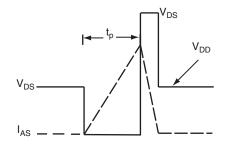


Fig. 12b - Unclamped Inductive Waveforms

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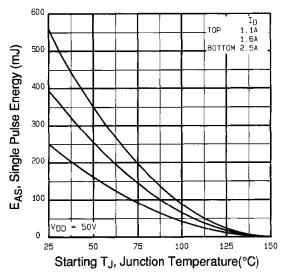


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

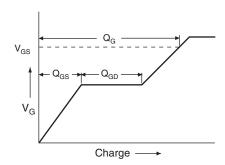


Fig. 13a - Basic Gate Charge Waveform

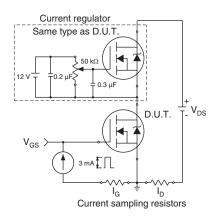
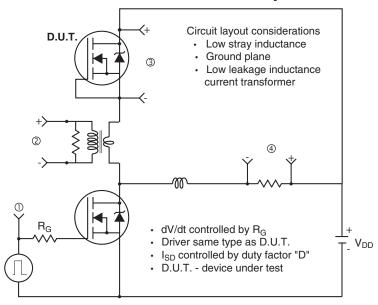
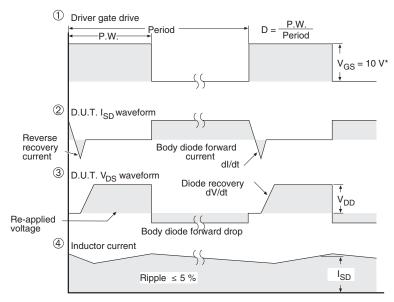


Fig. 13b - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel





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